Surface Grain Boundary Engineering of Alloy 600 for Improved Resistance to Stress Corrosion Cracking

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Abstract

In this paper, we demonstrate a novel method for grain boundary engineering in Alloy 600 using iterative cycles of ultrasonic nanocrystal surface modification (UNSM) and strain annealing to modify the near surface microstructure ($\sim 250 \mu\text{m}$) for improved stress corrosion cracking (SCC) resistance. These iterative cycles resulted in increased fraction of special grain boundaries whilst decreasing the connectivity of random grain boundaries in the altered near surface region. A disrupted random grain boundary network and a large fraction of low CSL boundaries ($\Sigma 3$ - $\Sigma 27$) reduced the propensity to sensitization. Slow strain rate tests in tetrathionate solutions at room temperature show that surface GBE lowered susceptibility to intergranular SCC. Detailed analysis of cracks using Electron Back-scattered Diffraction showed cracks arrested at J1(1-CSL) and J2 (2-CSL) type of triple junctions. The probability

for crack arrest, calculated using percolative models, was increased after surface GBE and explains the increase in resistance to SCC.

Keywords: EBSD, thermomechanical processing, nickel alloy, grain boundaries, residual stresses, twinning

1. Introduction

Grain boundary engineering (GBE) has been demonstrated as a viable method for improving the resistance to creep[1,2], hydrogen embrittlement[3], fatigue[4,5], corrosion[6–8] and stress corrosion cracking[2,9–14] (SCC) in austenitic stainless steels (SS), Ni based alloys and superalloys. GBE involves increasing the frequency of coincident site lattice (CSL) grain boundaries whilst disrupting the random grain boundary network through thermo-mechanical processing routes. Low grain boundary energy, resistance to grain boundary sliding and intergranular degradation, less susceptibility to impurity or solute segregation are some reasons that contribute to the “special” nature of CSL boundaries.

Thermo-mechanical processing routes involving cold rolling or uniaxial tension/compression and subsequent annealing have been used to increase the frequency of CSL boundaries[6,15]. One approach involves a single cycle of pre-straining the material followed by annealing at comparatively lower temperature for a long time. A multi-cycle approach including steps of moderate strains (6-30%) followed by relatively high temperature annealing for short times has also shown to increase the special grain boundary fraction[16,17]. In addition, the multi-cycle approach results in a disrupted random grain boundary network that correlates to improvements in fatigue, creep and corrosion resistance.

Detailed studies carried out by Bi et al. [18] have established that twin boundaries(especially coherent $\Sigma 3$) are more resistant to carbide precipitation and corrosion because the atomic structure is highly coherent as compared to high angle grain boundaries. In particular, $\Sigma 3$ and $\Sigma 9$ boundaries in grain boundary engineered SS304 have been observed

to more resistant to sensitization while $\Sigma 27$ and other CSL boundaries were not really “special” in terms of their resistance to sensitization and thus intergranular stress corrosion cracking (IGSCC)[19]. Thus, it has been suggested that increased fraction of $\Sigma 3$ and $\Sigma 9$ boundaries would likely improve the corrosion and stress corrosion resistance.

Alloy 600 and austenitic stainless steels have been known to be susceptible to stress corrosion cracking (SCC) in polythionic acid environments[20–25]. Susceptibility to SCC at low temperature in tetrathionate and thiosulfate environments has been attributed to Cr depletion in the area surrounding the grain boundary. A reduction in Cr depletion by disrupting the random grain boundary network or increasing the fraction of special boundaries should decrease the susceptibility to sensitization and SCC [6,18,19]. While GBE has been studied extensively to improve resistance to intergranular cracking, surface GBE has not been explored to the same extent.

In this paper, we propose a novel approach to engineer the near surface region by using ultrasonic nanocrystalline surface modification (UNSM)/ultrasonic peening followed by annealing to increase the fraction of special boundaries. Further, we present and discuss the effect of this surface grain boundary engineered material on the SCC behaviour in tetrathionate solution. To the best of our knowledge, there are no studies investigating the effects of surface GBE on SCC behaviour of Alloy 600.

2. Materials and Methods

2.1 Materials

Alloy 600 plate (2 mm thickness) with chemical composition as shown in Table 1 was sectioned into 15 mm x 15mm coupons using a wire EDM. The as received material was in annealed condition with a grain size of $\sim 10 \mu\text{m}$. UNSM is an advanced surface treatment that uses ultrasonic energy to strike a target (material surface) with a WC tip at a frequency of 20 kHz to induce strain in the near surface region of the material.

C	Mn	Si	S	Cr	Fe	Co	Cd	Ti	Cu	P	Al	Ni
0.08	0.16	0.18	0.001 max.	15.05	8.05	0.16	0.01	0.18	0.1	0.001 max.	0.08	Bal.

Table 1. Chemical composition of the Inconel Alloy 600 used in this study.

The amount of strain can be controlled by modifying the static and dynamic loads. A schematic of the UNSM process is shown in Figure 1. Static load (P_{st}), amplitude of ultrasonic vibration, scan speed and overlap ratio can be controlled during processing. Details of UNSM have been reported elsewhere in literature [26,27]. For grain boundary engineering, coupons were peened using a LM20 UNSM system (DesignMecha) and subsequently annealed in a lab furnace for 10 minutes at 950 °C or 1000 °C, then water quenched (WQ). Processing details for surface GBE are listed in Table 2. AR and ARGBE conditions have been grouped together as Set 1 while SA and SAGBE are categorized as Set 2. The static load was 20 N and the amplitude of ultrasonic vibration was 8 μ m. A scan speed of 3000 mm/minute and overlap interval of 30 μ m was used for UNSM processing in this study.

Figure 1. Schematic of the ultrasonic peening setup

After GBE treatments, samples were sectioned and cross sections were mounted in a conducting epoxy. For EBSD, each sample was ground to 1200 grit, electropolished in

87.5:12.5 vol.% CH₃OH:H₂SO₄ solution at 24 V, 15 s and finally polished with 0.05 µm colloidal silica suspension. EBSD orientation mapping was performed in a FEI XL-30 SEM with step size of 2 µm at 30 kV. OIM scans were analysed with the TSL OIM Analysis (version 7.1) package to calculate grain boundary character distribution (GBCD), grain size, boundary fractions and triple junction fractions. CSL grain boundaries were categorized according to Brandon criterion of $\Delta\theta \leq 15^\circ \Sigma^{-1/2}$ [28]. Boundaries with $3 < \Sigma < 29$ were considered to be CSL boundaries whereas boundaries with $\Sigma > 29$ were considered random high angle boundaries (HABs) and $\Sigma = 1$ as low angle boundaries (LABs). For triple junction analysis, only $\Sigma 3$, $\Sigma 9$ and $\Sigma 27$ were considered as CSL boundaries.

Designation	Detail
AR	As received
ARGBE	AR + 3 cycles of (UNSM + annealing at 950°C, 10 min, WQ)
SA	AR + Solution annealing at 1050°C, 10 min, WQ
SAGBE	SA + 3 cycles of (UNSM + annealing at 1000°C, 10 min, WQ)

Table 2. Designation and corresponding details of processing used in this study.

2.2 Residual stress and FWHM

Residual stresses were measured using $\sin^2\psi$ technique with a Proto LXR system, MnK α radiation and (311) peak of the austenite phase. To measure residual stress through depth, coupons were electropolished using 87.5:12.5 vol.% CH₃OH:H₂SO₄ solution to remove 10-50 µm layers. Full width at half maximum (FWHM) data was also recorded for each depth.

2.3 Double loop electrochemical potentiokinetic reactivation (DLEPR) tests

Baseline and grain boundary engineered samples were given a sensitization treatment at 650°C, 2h (water quenched) to induce precipitation of carbides. These samples were mechanically ground to 1200 grit, wet polished with 1 µm diamond suspension and finished with 0.05 µm colloidal silica suspension. DLEPR tests were performed in accordance with ASTM G108-94 in a solution composed of 0.01 M H₂SO₄ + 20 ppm KSCN using a Gamry Potentiostat (Reference 600). Samples were kept immersed in the test solution for 1 hour at open circuit potential before the start of each test. The scan rate was set at 0.5 mV/s for activation and reactivation loop and the sample size was 1 cm². Freshly prepared solution was de-aerated with high purity Ar gas before and during each test. All tests were performed at room temperature.

The following procedure was used to quantify sensitization in the annealed and GBE material after sensitization[29]. The degree of sensitization is reported as DL-EPR value (designated as R in %) which is the ratio of the current density in reactivation loop to that in the activation loop times 100.

$$R = \frac{I_r}{I_a} \times 100 \quad (1)$$

The DL-EPR value obtained is normalized with various parameters like grain boundary area (GBA), grain size, mean lineal intercept length (MIL). It should be noted that twins have been excluded from grain size analysis. The DL-EPR value of a given alloy condition (with ASTM grain size number of G') is normalized with the grain size (with ASTM grain size number of G) of the as-received material (SA) and is given by:

$$R' = R \times \sqrt{2^{G'-G}} \quad (2)$$

The DL-EPR values were also normalized with grain boundary area (S_v, expressed in mm²/mm³):

$$R_{GBA} = \frac{R}{S_v} \quad (3)$$

The DL-EPR values were also normalized with mean intercept length (designated by l):

$$R_{MIL} = \frac{R}{l} \quad (4)$$

Here l is expressed in μm . The grain boundary area and mean lineal intercept length can be obtained from the number of intercepts per unit length (N_L) of the test line [30]. The N_L can be calculated from the following equation [30]:

$$G = -3.2877 + 6.6439 \log_{10} N_L \quad (5)$$

where N_L is a number of intercepts per unit length and G is the ASTM grain size number. The mean lineal intercept (l) and the GBA, S_v , are given by [30]:

$$l = \frac{1}{N_L}, S_v = 2N_L \quad (6)$$

2.4 Slow strain rate tests (SSRT)

GBE samples were prepared by UNSM treating 2 sides a 2 mm thick Alloy 600 (in AR and SA conditions), then strain annealing. This was repeated 3 times with the same process parameters as listed in Table 2. All samples were then given a sensitization treatment at 650 °C, 2h. Flat samples with gage length of 6 mm were fabricated using wire EDM, polished to 1200 grit, degreased with acetone, dried and immersed in the test solution for 1 hour prior to straining. Samples were strained at rate of $2 \times 10^{-6} \text{ s}^{-1}$ for all tests. Slow strain rate tests (SSRT) were performed with a SSRT system (Cortest Inc. Willoughby, Ohio) driven by a servo motor and fitted with a custom built environmental chamber. Load and displacement values were recorded periodically and samples were strained to failure. Some SSRTs were interrupted after 10% nominal strain and held at constant load for 24 hours or failure. Test solutions (0.001- 0.01 M) were prepared using reagent grade $\text{Na}_2\text{S}_4\text{O}_6$ sodium

tetrathionate (Sigma-Aldrich) and distilled water. For certain tests, solution pH was adjusted with the appropriate amount of dilute H_2SO_4 .

3. Results

3.1 Residual stresses and FWHM

Residual stresses after ultrasonic peening were measured at different depths and plotted in Figure 2(a). The in-plane residual stresses are of the order of -1200 MPa and -700 MPa along (ϕ 90) and perpendicular (ϕ 0) to the scanning direction respectively. Differences in residual stresses in the 2 directions are attributed to the processing parameters and have been reported previously [26,31]. In addition, FWHM data plotted in Figure 2(b) shows high level of plastic strain at the surface which decreases gradually through depth. Significant peak broadening is observed at the surface and FWHM decreases to ~50% as represented by the normalized FWHM scale (secondary axis). The magnitude of residual stresses and FWHM indicate a high level of strain and plastic deformation that varies through depth. Significant strain and plastic deformation is observed within the first 250-300 microns after ultrasonic peening and hence the near surface region is likely to show strain induced microstructural changes after annealing.

Figure 2. (a) Residual stresses and (b) FWHM after UNSM in Alloy 600.

3.2 Microstructure

In this study, GBE treatment was applied to 2 sets of Alloy 600 with different initial starting conditions (AR and SA). An experimental matrix with different UNSM parameters and annealing temperatures was used to observe changes in grain boundary character distribution (GBCD) in the near surface region ($\sim 250\mu\text{m}$). GBCD statistics obtained were compared with those from thermo-mechanical processing routes in the FCC materials including Alloy 600 that have been reported previously[6,7,16,19].

Grain boundary maps from the AR and SA condition are shown in Figure 3 (a) and (c) respectively. The microstructure obtained as a result of repeating the (peening + annealing)

cycle for 3 times, designated as ARGBE and SAGBE are shown in Figure 3 (b) and (d) respectively. All orientation maps were obtained from 200-250 μ m perpendicular to the peened side. For analysis of triple junctions, only Σ 3, Σ 9 and Σ 27 have been considered. Triple junctions with no CSL boundaries, 1 CSL boundary, 2 CSL and 3 CSL boundaries have been classified as J0, J1, J2 and J3 respectively.

Grain boundary fractions (length), grain size and triple junction fractions for the 2 sets have been summarized in Figures 4 (a-c). In set 1(AR), the HAB fraction (length) decreased from 58% to 28% in ARGBE while the CSL fraction increased from 36% to 66%. The fraction of Σ 3 boundaries increased from 27% in the AR condition to 53% after GBE. More importantly, fractions of Σ 9 + Σ 27 increased from 3.4% (AR) to 10.2% (ARGBE). An increase in the Σ 9, Σ 27 fractions has been attributed to the Σ 3 regeneration model proposed by Randle et al. [32,33]. In addition, triple junction fractions extracted from the orientation maps show a sharp drop in fraction of J0 type from 48% to 10%. J2 and J3 fractions increase from 3%(AR) to 12%(ARGBE) and 4%(AR) to 29%(ARGBE) respectively. These changes in triple junction fractions are consistent with the GBE model proposed by Kumar et al. [16,34].

Figure 3. EBSD orientation maps showing the microstructure in the cross-section for (a) AR (b) ARGBE, (c) SA and (d) SAGBE conditions. Black lines denote random high angle grain boundaries and grey lines denote CSL boundaries ($\Sigma \leq 27$).

In set 2, the HAB fraction (length) decreased from 49% to 27% in SAGBE while the CSL fraction increased from 37% to 63%. The fraction of $\Sigma 3$ boundaries increased from 31% in the SA condition to 54% after GBE. $\Sigma 9 + \Sigma 27$ fractions increased from 2.2% (SA) to 7% (SAGBE). Similarly, J0 fraction dropped from 43% to 12% while J2 and J3 fractions increased from 3% (SA) to 11% (SAGBE) and 3% (SA) to 21% (SAGBE) respectively.

Grain size increased modestly from 9 μm to $\sim 12 \mu\text{m}$ in set 1 and from 11 μm to 15 μm in set 2 after grain boundary engineering.

Figure 4. (a) Grain boundary character distribution and grain size , (b) CSL boundary fraction and (c) triple junction fraction for each processing condition. Note that boundary and triple junction fractions are from $\sim 200 \mu\text{m}$ from the top surface.

3.3 Sensitization

After a sensitization treatment of 650°C, 2h (water quenched) and DLEPR tests were used to quantify the degree of sensitization for each condition. The as-received material was in annealed condition with a relatively finer grain size ($\sim 9 \mu\text{m}$). In case of the SA condition, the larger grain size and more carbon in the solid solution contributed to the increase in

susceptibility to sensitization. DOS values increased from 0.56 to 2.58 after the annealing treatment prior to sensitization as summarized in Table 3.

Sample	CSL fraction, %	R	R'	R _{GBA}	R _{MIL}
AR	36.2	0.56	0.5593	0.0053	0.0299
ARGBE	65.9	0.06	0.0217	0.0015	0.0012
SA	37.7	2.58	2.5766	0.0323	0.1032
SAGBE	62.5	0.04	0.0285	0.0006	0.0011

Table 3. CSL fraction and corresponding degree of sensitization (R) values for each processing condition.

Figure 5. SEM images showing microstructure after DLEPR test for (a) AR, (b) ARGBE, (c) SA and (d) SAGBE conditions. Samples were given a sensitization treatment for 2 hours at 650°C to induce sensitization prior to DLEPR tests.

More importantly, DOS values (R) for ARGBE was 0.06% as compared with 0.56% for the AR condition (Set 1). Similarly, DOS value was much lower (0.04%) for SAGBE condition

as compared with (2.58%) for the SA condition. Micrographs obtained after DLEPR tests for each condition are shown in Figure 5. Note that DLEPR tests were performed on the surface (within 50 μm from peened surface) and after sensitization. DOS values normalized by grain size, (R'), grain boundary area (R_{GBA}) and mean intercept length (R_{MIL}) also show similar trends. The dramatic reduction in DOS has been correlated with increased CSL fractions after thermo-mechanical processing [6,19,29]. The decrease in the DOS indicates higher SCC resistance and results from SSRTs in tetrathionate solution are presented in the next section.

3.4 Slow strain rate tests

The increase in the CSL fractions and $J_2/(1-J_3)$ fractions are indicative of the disruption in the grain boundary network after grain boundary engineering. A decrease in DOS (calculated from DLEPR tests) implies less Cr depletion after grain boundary engineering. The lower DOS can improve the SCC resistance of Alloy 600 in thiosulfate and tetrathionate solutions. Hence, SSR tests were performed to observe and quantify the decreased susceptibility to IGSCC after GBE. Stress-strain curves obtained from SSR tests in tetrathionate solution are as shown in Figure 6. Tests were performed at the same strain rate and in the same environment show a difference in SCC behavior. For Set 1, the elongation to failure was 85% for ARGBE as compared to 68% for AR condition in 0.01 M $\text{Na}_2\text{S}_4\text{O}_6$ solution. However, both AR and ARGBE showed ductile mode of a failure with no intergranular cracking. DOS values obtained from DLEPR tests had indicated that both the AR and ARGBE conditions were not severely sensitized so a more aggressive environment was used during SSRT. In acidified 0.001 M $\text{Na}_2\text{S}_4\text{O}_6$ solution with pH 3 (pH reduced by addition of dilute H_2SO_4), the strain to failure for AR was 26% as compared to ~50% for ARGBE condition. Addition of sulfuric acid to reduce the pH of the solution has been shown to be more aggressive towards austenitic stainless steels and Ni alloys [22,35].

In case of Set 2, the elongation to failure was only 15% for SA condition while SAGBE condition was about 26% in 0.01 M $\text{Na}_2\text{S}_4\text{O}_6$ solution. Analysis of the fracture surface after tests showed mixed mode of failure for SAGBE condition while SA condition showed 100% intergranular cracking. DLEPR tests conducted previously had indicated higher sensitization as compared to the as received material. The low elongation to failure in the SA condition and intergranular mode of failure indicates that the material was more severely sensitized as compared to the AR condition. Secondary cracks from the gage sections of samples were analyzed in greater detail and discussed in the next section.

To quantify the effect of LSP on the susceptibility to IGSCC in tetrathionate solutions, the following equation proposed by Abe et al. [36] was used to calculate the SCC index (I_{SCC}),

$$I_{\text{SCC}} = \left[\frac{1+e_n}{1+e_n^{\text{SCC}}} \right] \times \left[\frac{P_n}{P_n^{\text{SCC}}} - 1 \right] \quad (7)$$

where e_n and e_n^{SCC} are strains at the maximum load for load-elongation plot in air and environment respectively. P_n and P_n^{SCC} are the maximum loads for load-elongation plot in air and environment respectively. Table 4 summarizes the results from SSR tests in 0.01 M $\text{Na}_2\text{S}_4\text{O}_6$ solution. For Set 1, the I_{SCC} drops from 0.6 to 0.13 after GBE in acidified 0.001 M $\text{Na}_2\text{S}_4\text{O}_6$ solution (pH = 3). In case of Set 2, GBE reduces the I_{SCC} to 1.21 as compared to 2.17 for the SA condition.

Kikuchi patterns degrade due to strain and SAGBE samples had undergone close to 30% strain before failure during the SSR test in 0.01 M $\text{Na}_2\text{S}_4\text{O}_6$ solution. Further, SA and SAGBE samples were strained to 10% (nominal strain) and held for 24 hours (or failure) at the same stress level ($\pm 5\text{N}$). The SA sample failed in 8 hours after 10% strain while the SAGBE sample did not fail in 24 hours (after 10% strain) and the test was terminated. Cracks were observed on the gage section of both samples and were analyzed in greater detail. EBSD

orientation maps from regions including crack tips and their analysis are presented in the next section.

Specimen	%Elongation	Degree of Sensitization,%	I_{SCC}	Mode of failure
AR	63.75	0.56		Ductile
ARGBE	83.21	0.06		Ductile
AR_PH3	26.28	0.56	0.60	IGSCC
ARGBE_PH3	50.03	0.06	0.13	IGSCC
SA	16.19	2.5	2.17	IGSCC
SAGBE	25.33	0.04	1.21	IGSCC

Table 4. Summary of Stress-strain data from SSRT for each processing condition. All tests were performed at room temperature Strain rate was 2×10^{-6} /s.

Figure 6. Stress-strain curves for baseline and grain boundary engineered samples (after sensitization at 650°C, 2h, water quenched) in 0.01 M $\text{Na}_2\text{S}_4\text{O}_6$ solution. Strain rate: 2×10^{-6} /s. For tests designated PH3, dilute H_2SO_4 was added to 0.001 M $\text{Na}_2\text{S}_4\text{O}_6$ solution to reduce pH to 3.

3.5 SCC behavior

Detailed analysis of the fracture surface and secondary cracks from the gage section after SSR tests shows intergranular nature of cracking. EBSD orientation maps from areas including cracked boundaries were used to assess the cracking behavior. In case of SA

condition, elongation to failure was 16% and the mode of failure was intergranular in nature as shown in Figure 7 (b). A number of secondary cracks were observed in the gage section as shown in Figure 7 (a, c). Image quality (IQ) map overlaid with grain boundaries in Figure 7(d) shows the cracks following an intergranular path.

Figure 7. (a) SEM micrograph showing fracture surface and secondary cracking for SA condition after SSRT. (b) Micrograph showing secondary cracks in the gage section that were analyzed using EBSD. (c) High magnification micrograph of the fracture surface showing intergranular cracking. (d) Image quality EBSD map showing intergranular cracking overlaid with high angle boundaries in black and CSL boundaries in red. White arrow indicates the loading direction.

In case of SAGBE condition, a mixed mode of failure was observed as shown in Figure 8 (a, b). Very few cracks were observed on the gage section and even these did not propagate the sample width or depth. A secondary crack, shown in Figure 8(c), that was analyzed in greater detail showed crack deflection at multiple locations. For instance, the crack was

observed to have been arrested at a $\Sigma 3$ boundary. Note that the sample was strained to almost 30% and the kikuchi patterns degrade in locations of large strain especially near crack tips.

Figure 8. (a) SEM micrograph showing fracture surface and secondary cracking for SAGBE condition after SSRT. (b) High magnification micrographs of the fracture surface showing mixed mode of cracking. (c) Micrograph showing the location of a secondary crack that was analyzed in detail. (d) Image quality (IQ) map showing intergranular cracking overlaid with high angle boundaries in black and CSL boundaries in red. White arrow indicates the loading direction.

To analyze the interaction of SCC cracks with CSL boundaries in greater detail, we interrupted the SSRT test after nominal strain was 9% and the sample was held at this load/stress ($\pm 5\text{N}$) for 24 hours or till failure. The SAGBE sample did not fail (test stopped after 24 hours) while the SA sample failed in less than 6 hours.

Figure 9. (a, c) IQ maps showing crack arrest locations (black arrows) in SAGBE sample. (b, d) Corresponding skeletonized orientation maps showing the character of grain boundaries. Random high angle grain boundaries are colored black while CSL boundaries are colored red. The direction of loading is horizontal.

In case of SAGBE sample, multiple instances of crack arrest were observed on the gage section after the test. Orientation maps were recorded from multiple locations around the cracks. IQ and corresponding grain boundary character maps presented in Figure 9 (a, c) and (b, d) respectively show the character of grain boundaries ahead of the crack front. Cracks were observed to have been “arrested” on encountering a J2 type of triple junction. Several other instances where cracks were arrested or deflected from their path were observed in the SAGBE sample. In sharp contrast, the SA sample showed no instances of crack arrest or deflection as seen in Figure 10. More importantly, the cracks propagated the entire width of the sample and failed in 6 hours.

Figure 10. IQ map overlaid with grain boundaries from SA condition after the interrupted SSR test. Black lines denote random high angle boundaries while CSL boundaries are colored red.

4. Discussion

4.1 Microstructure evolution

Strain induced by UNSM was qualitatively measured by FWHM (shown in Figure 2) after the surface treatment. After 3 cycles of UNSM and subsequent annealing, the microstructure in the near surface region was significantly different as compared with the original microstructure. The network of random grain boundaries was observed to have broken down to smaller clusters after GBE. This disruption in random grain boundary networks has been reported after conventional thermo-mechanical processing routes in the literature [6,34]. The increase in CSL boundary fractions (by length) observed after SGBE in the near surface regions is similar to those reported after conventional single and multi-step thermo-mechanical processing. Also, the fracture characteristics are dependent on the distribution and interconnectivity of boundaries prone to crack propagation [16]. Therefore, changes to the triple junction distributions provide a direct co-relation to failure characteristics. In this study, we observed J2 and J3 fractions were significantly higher while

the J0 fraction decreased after GBE in the near surface region. These characteristics are consistent with other observations of triple junction distribution after GBE [16,34,37].

The mechanism is likely to be similar to conventional GBE with the UNSM induced strain that decreases gradually from the near surface region to the interior. The multi-cycle treatment allows more possibilities for grain boundary migration and this further disrupts the random grain boundary network. Multiple interactions of twin boundaries (and its variants) with other random boundaries may introduce disruptions in the boundary network[34,38,39]. Though the strain induced by UNSM has not been quantified, residual stress and FWHM (Figure 2) provide a qualitative description of the strain in the near surface region. UNSM or other mechanical surface treatments can induce strain in regions to ~ 250-500 μm from the surface and thus could be used for near net shaped components or areas particularly prone to cracking. Alyousif et al. [40] reported a single step shot peening and annealing treatment to modify the microstructure in 304 stainless steel. They observed a decreasing gradient in twin fractions from the surface up to 100 μm . In this study, we used a multi-cycle approach to increase the CSL fractions and disrupt the random high angle grain boundary network to a depth of 250 μm .

4.2 Effect of increased CSL fraction on corrosion behavior

The decrease in DOS after GBE in austenitic stainless steels and Alloy 600 has been reported previously in a number of studies [6,7,18,19,29]. More significantly, this decrease in DOS has been attributed to increased fraction of twin boundaries and its variants. Additionally, CSL boundaries have been shown to be more resistant to precipitation of carbides and Cr depletion [18,41]. Jones and Randle [19] reported that $\Sigma 3$ (~ 97%) and $\Sigma 9$ (~ 80%) were resistant to sensitization while $\Sigma 27$ and random high angle boundaries were attacked and not particularly resistant. A decrease in DOS by almost an order of magnitude

suggests that the high CSL fraction as well as numerous disruptions in HAB network reduced Cr depletion indicated by the lower DOS.

We observed that cracks were deflected or mitigated on encountering J2 type of triple junctions after surface GBE as shown in Figure 9. Similarly, improvements in high temperature fatigue [4] and hydrogen embrittlement [3] have been attributed to an increase in fractions of special boundaries particularly when the mode of failure is intergranular. Intergranular attack and stress corrosion cracks usually initiate at the surface and propagate to the interior along random grain boundaries. Though modification in grain boundary network is confined to ~200-300 μm in the near surface region, cracks would encounter more resistant CSL boundaries. Other studies show that $\Sigma 3$ boundaries are significantly more resistant to cracking than HAB [10,38,42]. While a few $\Sigma 3$ boundaries have been observed to crack and the “special” nature of $\Sigma 3^n$ variants ($n = 2, 3$) with respect to their cracking resistance is under debate. Additionally, even some random HABs have been observed to “resistant” if they are unfavorably oriented to the applied stress direction [38,43].

A few percolation models have been proposed to determine the probability for crack deflection or arrest when the crack encounters a resistant grain boundary [16,44–46]. Marrow et al.[45] observed cracks that were arrested by J1 and J2 type of triple junctions in sensitized 304 stainless steels after SCC tests in tetrathionate solutions at room temperature. Gertsman and Bruemmer[38] also observed cracks that were arrested at J2 type junctions and coherent $\Sigma 3$ boundaries were resistant to SCC. They also reported several $\Sigma 9$ and $\Sigma 27$ boundaries and $\Sigma 3$ boundaries with large deviations from ideal misorientation had cracked. The probability for crack arrest at a triple junction was calculated according to the 3 models proposed by Kumar et al. [39], Palumbo et al. [46] and Marrow et al. [45] and have been plotted in Figure 11.

Palumbo et al. also proposed the following relation (Equation 8) to calculate the probability (P) of crack arrest,

$$P = (f_{sp}^2) + 2 [(f_0)(f_{sp})(1 - f_{sp})] \quad (8)$$

Where f_{sp} is the fraction of special boundaries and f_0 is the fraction of interfaces in the distribution that are unfavorably oriented to the stress axis. This model relates the probability for crack arrest to the f_{sp} but does not consider the spatial arrangement of these special boundaries in the microstructure.

It has been observed that fracture characteristics are primarily dependent on spatial distribution and interconnectivity of boundaries prone to crack propagation. To quantify the effect of improvement in the GBCD on the spatial connectivity of grain boundaries in two dimensions, triple junction distribution was evaluated [16]. Assuming J3 type of junctions to be non-entities in crack propagation, Kumar et al.[16] proposed (Equation 9) that the percolative paths in the microstructure would be broken if the following inequality/percolation ratio(P_R) holds,

$$P_R = \frac{J2}{(1-J3)} \geq 0.35 \quad (9)$$

Marrow et al.[45] observed cracks arrested at both J2 and J1 type of triple junctions and proposed the following (Equation 10),

$$P = \frac{[f_a J2 + f_b J1]}{(1-J3)} \quad (10)$$

where f_a and f_b (considered 1 and 0.5 respectively) are geometrical factors to account for unfavorably oriented sensitized boundaries at the triple junction. These three probabilistic models provide a basis to evaluate microstructures that are indicative of the resistance to SCC.

The probability for crack arrest was observed to increase from 0.3 to about 0.5 after SGBE according to the model proposed by Marrow et al. and from 0.3 to 0.6 according to the model proposed by Palumbo et al. Similarly, P_R was observed to increase from 0.03 to 0.18 as per the model proposed by Kumar et al. The decrease in SCC susceptibility can therefore be attributed to increase in the probability of crack arrest and percolation ratio calculated using the three models. It has been suggested that as the ratio of $J_2/(1-J_3)$ is equal to or exceeds 0.35, percolative paths in the microstructure will be broken [16]. Tsurekawa et al. also reported higher resistance to percolative intergranular corrosion in SS304L for microstructures with higher P_R [47]. They also found that triple junction distribution fraction was a more important parameter to rank than maximum random boundary cluster length or GBCD. In this study, surface GBE increased the ratio (P_R) by five times that in the baseline microstructure and this reduced the SCC susceptibility significantly. This further demonstrates that surface GBE increased the resistance to SCC in Alloy 600 in tetrathionate solutions. Since only $\Sigma 3$, $\Sigma 9$ and $\Sigma 27$ CSL boundaries have been considered for triple junction analysis, this type of analysis is a more conservative approach to evaluate the relative resistance of microstructure to SCC.

Figure 11. Probability for crack arrest as proposed by Palumbo et al. [46] and Marrow et al. [45] and percolation ratio, P_R by Kumar et al. [16], for all conditions. Only $\Sigma 3$, 9 and 27 CSL boundaries have been considered in the triple junction analysis.

5. Conclusions

The following conclusions can be drawn from this study,

1. The fraction of special boundaries was increased in the 200 – 300 μm layer underneath the surface after iterative steps of ultrasonic peening (inducing high strain in the near surface region) and high temperature annealing.
2. The increase in fraction of low CSL boundaries, J1, J2 and J3 type of triple junctions and corresponding decrease in J0 type was similar to that observed in single or multi-step conventional GBE processing schemes.
3. Surface GBE decreased the degree of sensitization significantly (an order of magnitude) and a SSRT results show an increase in elongation to failure and decrease in SCC susceptibility.
4. Detailed analysis of cracks on the gage section after SSR tests show cracks being deflected or mitigated at J2 type to triple junctions. Thus increase in fraction of special grain boundaries may have a dual effect of decreasing Cr depletion and mitigating intergranular cracks.
5. Calculations using percolative models showed that SGBE increased the probability for crack arrest and ratio (P_R).

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